

NPN Transistor Bare Die – MPSH10

VHF / UHF RF transistor in bare die form Complement PNP MPSH81

Rev 1.0 02/09/17

Features:

- High f_T min = 650MHz
- Maximum capacitance 0.7pF
- High Reliability Gold Back Metal
- High Reliability tested grades for Military + Space

Ordering Information:

The following part suffixes apply:

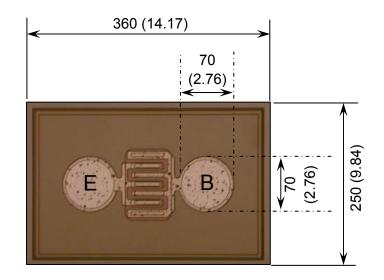
- No suffix MIL-STD-750 /2072 Visual Inspection
- "H" MIL-STD-750 /2072 Visual Inspection+ MIL-STD-38534 Class H LAT
- "K" MIL-STD-750 /2072 Visual Inspection+ MIL-STD-38534 Class K LAT

LAT = Lot Acceptance Test.

For further information on LAT process flows see below.

www.siliconsupplies.com\quality\bare-die-lot-qualification

Die Dimensions in µm (mils)



E = EMITTER **B** = BASE

DIE BACK = COLLECTOR

Supply Formats:

- Default Die in Waffle Pack (400 per tray capacity)
- Sawn Wafer on Tape Specific request
- Unsawn Wafer Specific request
- With additional electrical selection Specific request
- Sawn as pairs or adjacent pair pick Specific request

Mechanical Specification

Die Size (Excluding Saw Street)	360 x 250 14.17 x 9.84	μm mils	
Emitter & Base Pad Size	70 x 70 2.95 x 3.74	µm mils	
Die Thickness	180 (±20) 7.09 (±0.79)	μm mils	
Top Metal Composition	Al - 1.3μm		
Back Metal Composition	AuAs - 0.9µm		





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Absolute Maximum Ratings T_A = 25°C unless otherwise stated

PARAMETER	SYMBOL	VALUE	UNIT
Collector-Base Voltage	V_{CBO}	30	V
Collector-Emitter Voltage	V _{CEO}	25	V
Emitter-Base Voltage	V _{EBO}	3	V
Collector Current	Ic	50	mA
Collector Power Dissipation	Pc	225	mW
Junction & Storage Temperature	T _J , T _{stg}	-55 to 150	°C

Electrical Characteristics T_A = 25°C unless otherwise stated

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Collector-Base Breakdown Voltage	V _{(BR)CBO}	$I_{C} = 100 \mu A, I_{E} = 0$	30	-	-	V
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	$I_{C} = 1 \text{mA}, I_{B} = 0$	25	-	-	V
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	$I_E = 10\mu A, I_C = 0$	3	-	-	V
Collector Cut-off Current	Ісво	V _{CB} = 25V, I _E = 0	-	-	100	nA
		$V_{CB} = 25V, I_E = 0, T_A = 150^{\circ}C^1$	-	-	1	μA
Emitter Cut-off Current	I _{EBO}	V _{EB} = 2V	-	-	100	nA
ON CHARACTERISTICS						
Forward-Current Transfer Ratio	h _{FE}	$V_{CE} = 10V$, $I_C = 4mA$	60	-	-	-
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_C = 4mA$, $I_B = 0.4mA$	-	-	0.5	V
Base-Emitter On Voltage	V _{BE(on)}	$V_{CE} = 10V$, $I_C = 4mA$	-	-	0.95	V
SMALL-SIGNAL CHARACTERISTICS ¹						
Current-Gain Bandwidth Product	f _T	I _C = 4mA, V _{CE} = 10V, f = 100MHz	650	-	-	MHz
Collector-Base Capacitance	C _{cb}		-	-	0.7	
Common-Base Feedback Capacitance	C _{rb}	$V_{CB} = 10V, I_E = 0, f = 1MHz$	-	-	0.65	pF
Collector Base Time Constant	rb'C _c	I _C = 1mA, V _{CB} = 10V, f = 31.8 MHz	-	-	9	ps

Note 1: Not production testing in die form, characterized by chip design.

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